

Search Notes

Application/Control No.

10/719,341

Examiner

Phallaka Kik

Applicant(s)/Patent under
Reexamination

LYSAGHT, PATRICK

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	16,18	12/23/2006	PK
713	1,2,100	12/23/2006	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	16,18	12/23/2006	PK
713	1,2,100	12/23/2006	PK
--USPGPUB (see attached)		12/23/2006	PK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Class/sub searched: 716/1-18; 713/1,2,100 (see attached)	12/23/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	12/23/2006	PK
IEE/IEEE Xplore (see attached)	12/23/2006	PK